

EMC Test Report

Report No.: STS2308301E01

Issued for

SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD

202, Building A2, Silicon Valley Power Intelligent Terminal
Industrial Park, No. 20, Dafu Industrial Zone, Kukeng
Community, Guanlan Street, Longhua District, Shenzhen
China

Product Name: Smart Phone

Brand Name: OUKITEL

Model Name: WP30 Pro

Series Model(s): WP30, WP30 S, WP30 Ultra, WP30 TITAN

Test Standards: EN 55032:2015/A11:2020
EN IEC 61000-3-2:2019/A1:2021
EN 61000-3-3:2013/A2:2021
EN 55035:2017/A11:2020

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TEST REPORT

Applicant's Name: SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
Address: 202, Building A2, Silicon Valley Power Intelligent Terminal Industrial Park, No. 20, Dafu Industrial Zone, Kukeng Community, Guanlan Street, Longhua District, Shenzhen China

Manufacturer's Name: SHENZHEN YUNJI INTELLIGENT TECHNOLOGY CO.,LTD
Address: 202, Building A2, Silicon Valley Power Intelligent Terminal Industrial Park, No. 20, Dafu Industrial Zone, Kukeng Community, Guanlan Street, Longhua District, Shenzhen China

Product Description:
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EN 55035:2017/A11:2020

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Date of Test:
Date of Receipt of Test Item: 01 Aug. 2023
Date (s) of Performance of Tests.....: 01 Aug. 2023 ~ 21 Sept. 2023
Date of Issue: 21 Sept. 2023
Test Result: **Pass**

Testing Engineer : Star Deng
(Star Deng)

Technical Manager : Bulun
(Bulun)

Authorized Signatory : Chris Chen
(Chris Chen)





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Revision History

Rev.	Issue Date	Report No.	Effect Page	Contents
00	21 Sept. 2023	STS2308301E01	ALL	Initial Issue

1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission				
Standard	Test Item	Limit	Judgement	Remark
EN 55032:2015/A11:2020	Conducted Emission on AC And Telecom Port 150kHz to 30MHz	Class B	PASS	
	Radiated Emissions	Class B	PASS	NOTE (1)
EN IEC 61000-3-2:2019/A1:2021	Harmonic Current Emission	Class A	PASS	NOTE (2)
EN 61000-3-3:2013/A2:2021	Voltage Fluctuations & Flicker	-----	PASS	
EMC Immunity				
Section	Test Item	Performance Criteria	Judgement	Remark
EN 55035:2017/A11:2020				
EN 61000-4-2:2009	Electrostatic discharges	B	PASS	
EN IEC 61000-4-3:2020	Continuous RF electromagnetic field disturbances	A	PASS	
EN 61000-4-4:2012	Electrical fast transients/burst	B	PASS	
EN 61000-4-5:2014/A1:2017	Surges	B	PASS	
EN 61000-4-6:2014+AC:2015	Continuous induced RF disturbances	A	PASS	
EN 61000-4-8:2010	Power frequency magnetic field	A	PASS	
EN IEC 61000-4-11:2020	Voltage dips and interruptions	B / C / C	PASS	NOTE (2)

Note: (1) If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz.

If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.

If the highest frequency of the internal sources of the EUT is between 500 MHz and 1GHz, the measurement shall only be made up to 5 GHz.

If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times of the highest frequency or 6 GHz, whichever is less.

(2) Voltage Dip: 100% reduction – Performance Criteria **B**

Voltage Dip: 30% reduction – Performance Criteria **C**

Voltage Interruption: 100% Interruption – Performance Criteria **C**

(3) N/A=Not Applicable.



1.1 TEST FACTORY

Company Name:	SHENZHEN STS TEST SERVICES CO.,LTD.
Address:	101, Building B, Zhuoke Science Park, No.190 Chongqing Road, ZhanChengShequ, Fuhai Sub-District, Bao'an District, Shenzhen, Guang Dong, China
Telephone:	+86-755 3688 6288
Fax:	+86-755 3688 6277
Registration No.:	FCC test Firm Registration Number: 625569
	IC test Firm Registration Number: 12108A
	A2LA Certificate No.: 4338.01

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expanded uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately **95 %**.

A. Conducted Measurement:

Test Site	Method	Measurement Frequency Range	U · (dB)	NOTE
STSC01	CISPR 16-4-2	9KHz ~ 150KHz	2.14	
		150KHz ~ 30MHz	2.54	

B. Radiated Measurement:

Test Site	Method	Measurement Frequency Range	U · (dB)	NOTE
STSC02	CISPR 16-4-2	30MHz ~ 1000MHz	3.94	
		1GHz ~ 6 GHz	4.59	

2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF THE EUT

Product Name	Smart Phone	
Brand Name	OUKITEL	
Model Name	WP30 Pro	
Series Model(s)	WP30, WP30 S, WP30 Ultra, WP30 TITAN	
Model Difference	All the model are the same circuit and RF module, except model names and appearance of the color.	
Product Description	The EUT is a Smart Phone. ITE equipment having a primary function of either (or a combination of) entry, storage, display, retrieval, transmission, processing, switching, or control of data and/or telecommunication messages and which may be equipped with one or more ports typically for information transfer.	
Frequency Bands	5G NR	SA: N78: 3300-3800MHz(TX), 3300-3800MHz(RX) NSA: LTE Band 1+N78
	FM	87.5-108MHz
Modulation Mode	5G NR	DFT-s-OFDM: PI/2 BPSK, QPSK, 6QAM, 64QAM, 256QAM CP-OFDM: QPSK, 16QAM, 64QAM, 256QAM
	FM	FM
Rating	Input: DC 5V	
Battery	Rated Voltage: 7.74V Charge Limit Voltage:8.9V Capacity: 5500mAh	
Adapter	Input: 100-240V50/60Hz 0.2A Output: Input: 100-240V~50/60Hz 1.8A Output: DC 5.0V 3.0A 15.0W OR DC 9.0V 3.0A 27.0W OR DC 12.0V 3.0A 36.0W OR DC 15.0V 3.0A 45.0W OR DC 20.0V 5.0A 100.0W MAX PPS: DC 3.6V-20.0V 6.0A 120.0W MAX	
Hardware Version Number	M159-MUB-V2	
Software Version Number	OUKITEL_WP30_Pro_V09_20230804	

2.2 DESCRIPTION OF THE TEST MODES

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanning tested based on the consideration of following EUT operation mode or test configuration mode which possibly have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	PC+USB Transmitting+SD Card
Mode 2	Charging + Audio + Video + Earphone
Mode 3	Charging + FM

For Conducted Test	
Final Test Mode	Description
Mode 1	PC+USB Transmitting+SD Card

For Radiated Test	
Final Test Mode	Description
Mode 1	PC+USB Transmitting+SD Card

For EMS Test	
Final Test Mode	Description
Mode 1	PC+USB Transmitting+SD Card
Mode 2	Charging + Audio + Video + Earphone
Mode 3	Charging + FM

Note:

1. For conducted emission test, test mode 1 was the worst case and only this mode was presented in this report.
2. For radiated emission test, test mode 1 was the worst case and only this mode was presented in this report.
3. The device has been tested with normal voltage (For 110V, 50/60Hz and 230V, 50/60Hz). The report only shows the worst result which is tested with 230V/ 50Hz.

2.3 DESCRIPTION OF THE TEST SETUP

The EUT has been tested with associated equipment below and the test setup please refer to appendix 1 - test setup.

Necessary accessories

Item	Equipment	Mfr/Brand	Model/Type No.	Length	Note
	Adapter	N/A	HJ-PD120W-EU	N/A	N/A
	Type-C Cable	N/A	N/A	100cm	NO

Support units

Item	Equipment	Mfr/Brand	Model/Type No.	Length	Note
	Notebook Adapter	DELL	HSTNN-CA15	N/A	N/A
	Notebook	DELL	500-320cx	N/A	N/A
	DC Cable	N/A	N/A	110cm	NO

Note:

- (1) For detachable type I/O cable should be specified the length in cm in 『Length』 column.
- (2) “YES” means “with core”; “NO” means “without core”.

2.4 MEASUREMENT INSTRUMENTS LIST

2.4.1 CONDUCTED TEST SITE

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
EMI Test Receiver	R&S	ESCI	101427	2022.09.28	2023.09.27
LISN	R&S	ENV216	101242	2022.09.28	2023.09.27
LISN	ETS	3810/2NM	00023625	2022.09.28	2023.09.27
Absorbing Clamp	R&S	MDS-21	100668	2023.02.28	2024.02.27
CE Cable	N/A	C01	N/A	2022.09.28	2023.09.27
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29
Testing Software	EZ-EMC(Ver.STSLAB-03A1 CE)				

2.4.2 RADIATED TEST SITE

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
EMI Test Receiver	R&S	ESCI	101427	2022.09.29	2023.09.28
Bi-log Antenna	TESEQ	CBL6111D	45873	2021.10.08	2023.10.07
Horn Antenna	SCHWARZBECK	BBHA 9120D	1343	2022.09.28	2023.09.27
Pre-amplifier(1-26.5G)	Agilent	8449B	3008A02383	2023.2.28	2024.2.27
Pre-amplifier(0.1M-3GHz)	EM	EM330	060665	2023.2.28	2024.2.27
Spectrum Analyzer	Agilent	N9020A	MY49100060	2022.09.28	2023.09.27
RE Cable (9K-1G)	N/A	R01	N/A	2022.09.28	2023.09.27
RE Cable (1-26G)	N/A	R02	N/A	2022.09.28	2023.09.27
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29
Testing Software	EZ-EMC(Ver.STSLAB-03A1 RE)				

2.4.3 HARMONICS AND FLICKER

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
Harmonic Voltage & Flicker	LAPLACE	AC 2000A	311217	2022.09.28	2023.09.27
AC Power Source	MTONI	PHF-5010	631169	2022.09.28	2023.09.27
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29
Testing Software	HA-PC Link Version 3.03				

2.4.4 ESD

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
ESD TEST GENERATOR	TESQ	NSG438	1175	2022.09.28	2023.09.27
Temperature & Humidity	N/A	WS1066	N/A	2023.02.28	2024.02.27

2.4.5 SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
Surger Generator	HTEC	HCWG 100	225202	2023.03.01	2024.02.29
Surger Generator	HTEC	HTW	152104	2022.09.28	2023.09.27
VOLTAGE DIPS & INTERRUPTIONS Generator	HTEC	HPFS 161P	143803	2023.02.28	2024.02.27
EFT/B Generator	HTEC	HEFT 51	192001	2022.09.28	2023.09.27
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29

2.4.6 RS

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
Power Meter	Agilent	E4419B	QB43312265	2022.09.28	2023.09.27
Power Sensor	Hp	E9300A	US39210170	2022.09.28	2023.09.27
Power Sensor	Hp	E9300A	US39210476	2022.09.28	2023.09.27
Signal Generator	Agilent	N5181A	MY56144718	2022.09.28	2023.09.27
Power Amplifier	MICOTOP	MPA-80-1000-250	MPA1711489	2022.09.28	2023.09.27
Power Amplifier	MICOTOP	MPA-1000-6000-100	MPA1904132	2022.09.28	2023.09.27
RS Test Antenna (0.08-1GHz)	SCHWARZBECK	VULP 9118E	000999	N/A	N/A
RS Test Antenna (1-10GHz)	SCHWARZBECK	STLP 9149	000648	N/A	N/A
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29
Testing Software	EMC-S V1.4.0.53				

2.4.7 INJECTION CURRENT

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
CS	SCHLODER	CDG-6000-25	126A1280/2014	2022.09.28	2023.09.27
CDN	SCHLODER	CDN-M2+3	A2210275/2014	2022.09.28	2023.09.27
EM Clamp	SCHLODER	EMCL-20	132A1283	2022.09.28	2023.09.27
Attenuator	Nemtest	ATT-6DB-100	A100W224	2022.09.28	2023.09.27
Temperature & Humidity	Mieo	HH660	N/A	2022.09.30	2023.09.29

2.4.8 PFMF

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibration	Calibrated Until
MF Generator	HTEC	HMFG-COMB	143903	2022.9.28	2023.9.27
Magnetic Field Coil	HTEC	HCOIL 100	143808	2022.9.28	2023.9.27
Temperature & Humidity	Mieo	HH660	N/A	2022.9.30	2023.9.29

3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 REQUIREMENTS FOR CONDUCTED EMISSIONS FROM THE AC MAINS POWER PORTS OF THE CLASS A EQUIPMENT

FREQUENCY (MHz)	Coupling device	Detector type / bandwidth	Class A limits dB(μV)
0.15 ~ 0.5	AMN	Quasi Peak / 9 kHz	79
0.5 ~ 30			73
0.15 ~ 0.5	AMN	Average / 9 kHz	66
0.5 ~ 30			60

3.1.2 REQUIREMENTS FOR CONDUCTED EMISSIONS FROM THE AC MAINS POWER PORTS OF THE CLASS B EQUIPMENT

FREQUENCY (MHz)	Coupling device	Detector type / bandwidth	Class B limits dB(μV)
0.15 ~ 0.5	AMN	Quasi Peak / 9 kHz	66 - 56*
0.5 ~ 5			56
5 ~ 30			60
0.15 ~ 0.5	AMN	Average / 9 kHz	56 - 46*
0.5 ~ 5			46
5 ~ 30			50

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

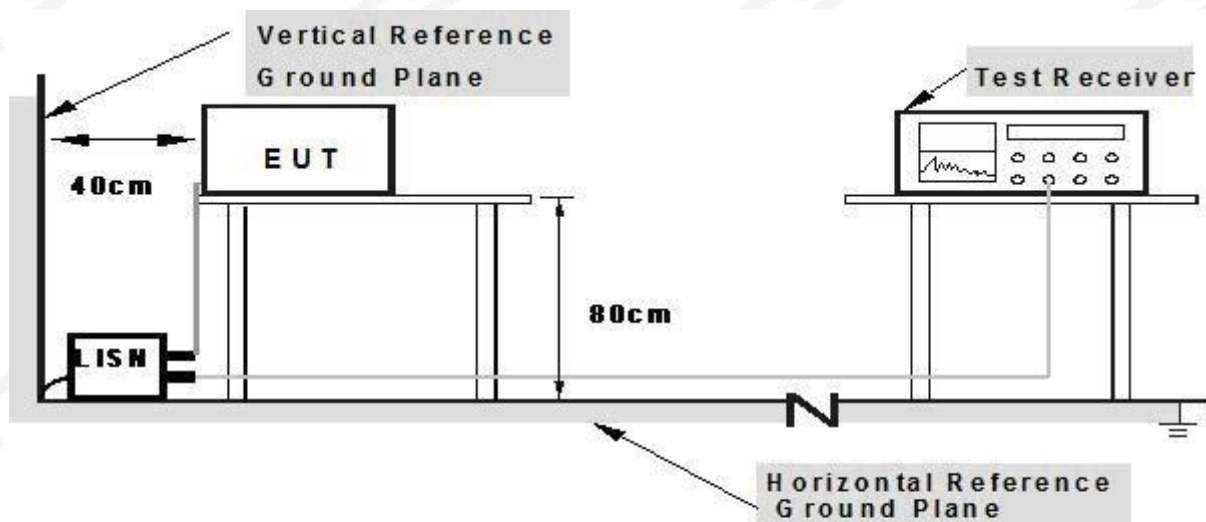
The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

3.1.3 TEST PROCEDURE

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.4 TEST SETUP



Note: 1. Support units were connected to second LISN.

2. Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.



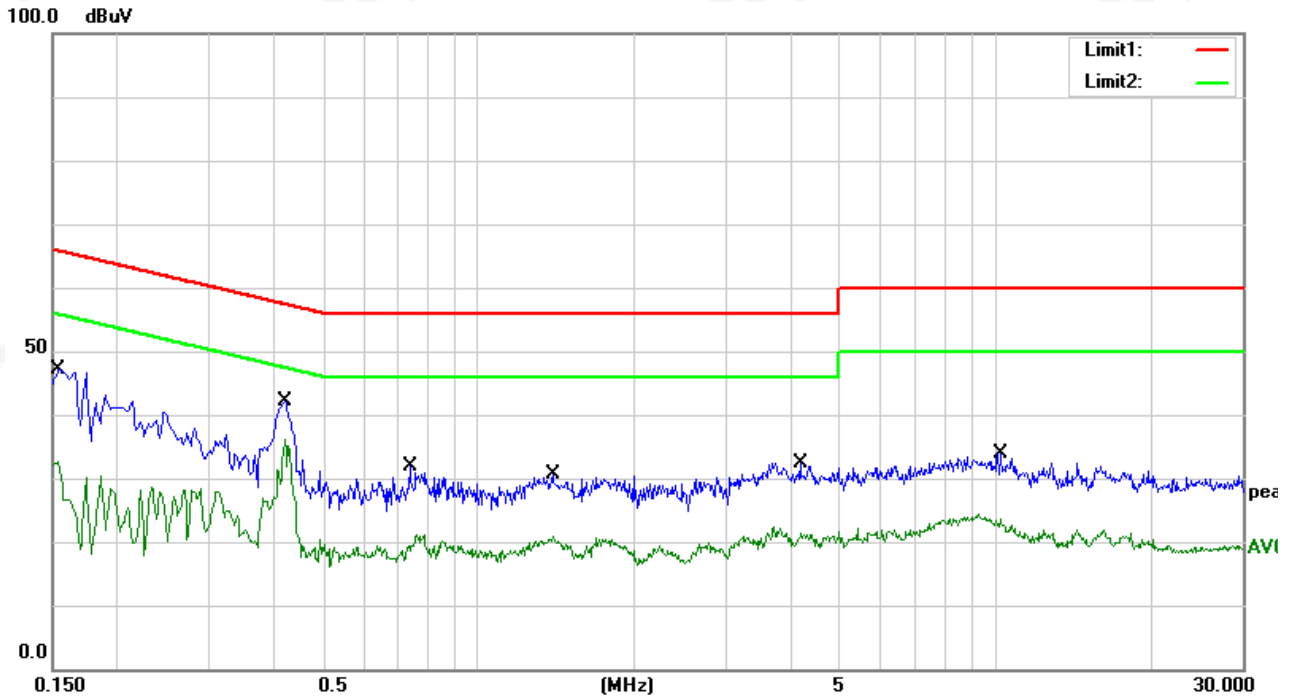
3.1.6 TEST RESULTS

Temperature:	25.8°C	Relative Humidity:	57%
Phase:	L	Test Mode:	Mode 1
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.03

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1540	26.74	20.30	47.04	65.78	-18.74	QP
2	0.1540	12.31	20.30	32.61	55.78	-23.17	AVG
3	0.4220	21.65	20.55	42.20	57.41	-15.21	QP
4	0.4220	15.57	20.55	36.12	47.41	-11.29	AVG
5	0.7380	11.48	20.36	31.84	56.00	-24.16	QP
6	0.7380	0.86	20.36	21.22	46.00	-24.78	AVG
7	1.3940	10.26	20.34	30.60	56.00	-25.40	QP
8	1.3940	0.45	20.34	20.79	46.00	-25.21	AVG
9	4.1860	11.96	20.52	32.48	56.00	-23.52	QP
10	4.1860	1.93	20.52	22.45	46.00	-23.55	AVG
11	10.1820	13.03	20.94	33.97	60.00	-26.03	QP
12	10.1820	3.43	20.94	24.37	50.00	-25.63	AVG

Remark:

1. All readings are Quasi-Peak and Average values
2. Margin = Result (Result = Reading + Factor)–Limit
3. Factor = Insertion loss + Cable loss





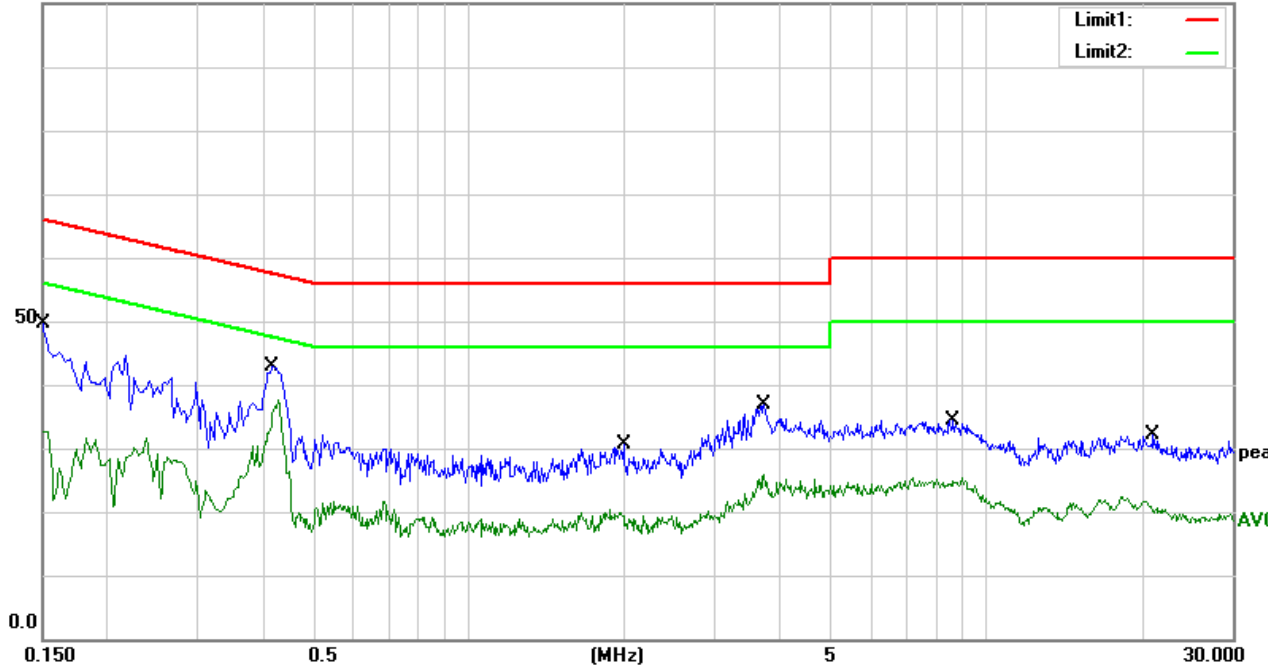
Temperature:	25.8°C	Relative Humidity:	57%
Phase:	N	Test Mode:	Mode 1
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.03

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1500	29.35	20.29	49.64	66.00	-16.36	QP
2	0.1500	12.30	20.29	32.59	56.00	-23.41	AVG
3	0.4180	22.36	20.56	42.92	57.49	-14.57	QP
4	0.4180	17.08	20.56	37.64	47.49	-9.85	AVG
5	1.9940	10.14	20.39	30.53	56.00	-25.47	QP
6	1.9940	0.06	20.39	20.45	46.00	-25.55	AVG
7	3.7380	16.32	20.49	36.81	56.00	-19.19	QP
8	3.7380	5.39	20.49	25.88	46.00	-20.12	AVG
9	8.6580	13.66	20.77	34.43	60.00	-25.57	QP
10	8.6580	4.55	20.77	25.32	50.00	-24.68	AVG
11	21.1220	9.17	22.87	32.04	60.00	-27.96	QP
12	21.1220	-0.55	22.87	22.32	50.00	-27.68	AVG

Remark:

1. All readings are Quasi-Peak and Average values
2. Margin = Result (Result = Reading + Factor) – Limit
3. Factor = Insertion loss + Cable loss

100.0 dBuV



3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF THE RADIATED EMISSION MEASUREMENT

FREQUENCY (MHz)	Distance (m)	Detector type/ bandwidth	Class A	Class B
			dBuV/m	dBuV/m
30 ~ 230	3	Quasi peak/ 120 kHz	50	40
230 ~ 1000	3	Quasi peak/ 120 kHz	57	47
1000 ~ 3000	3	Peak /1 MHz	76	70
3000 ~ 6000	3	Peak /1 MHz	80	74
1000 ~ 3000	3	AV/1 MHz	56	50
3000 ~ 6000	3	AV/1 MHz	60	54

Notes:

- (1) The tighter limit applies at the band edges.
- (2) Emission level (dBuV/m) = 20log Emission level (uV/m).

3.2.3 TEST PROCEDURE

- a. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 3 meter semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. EUT as the center to the edge of the auxiliary device, the distance from the maximum edge to the center of the antenna is 3 meter.
- c. The height of antenna is varied from 1 meter to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meter and the rotatable table was turned from 0 degrees to 360 degree to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1GHz.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.2.4 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz

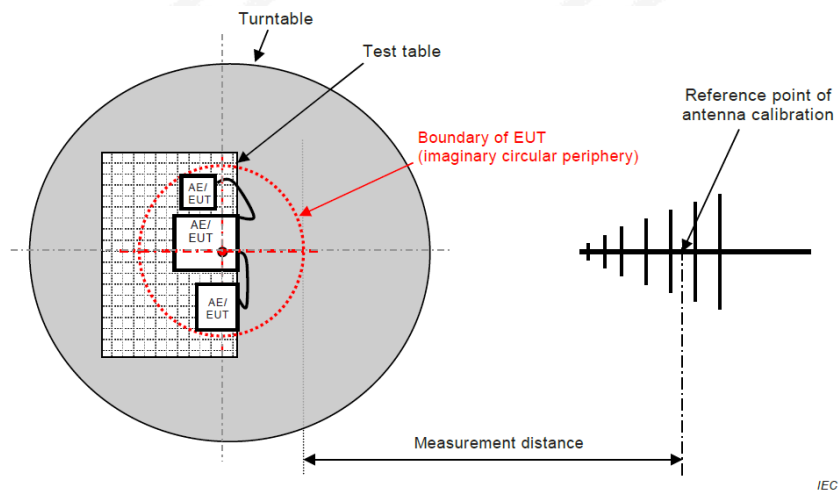


Figure C.1 – Measurement distance

(B) Radiated Emission Test Set-Up Frequency Above 1GHz

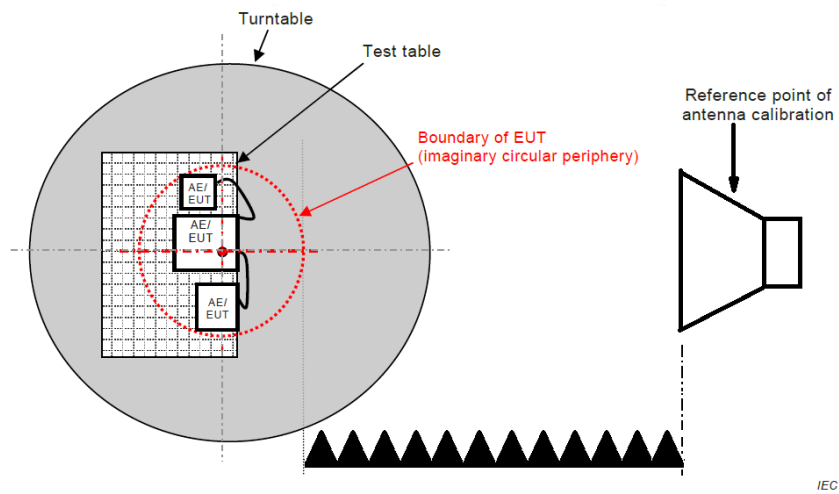


Figure C.1 – Measurement distance

3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.

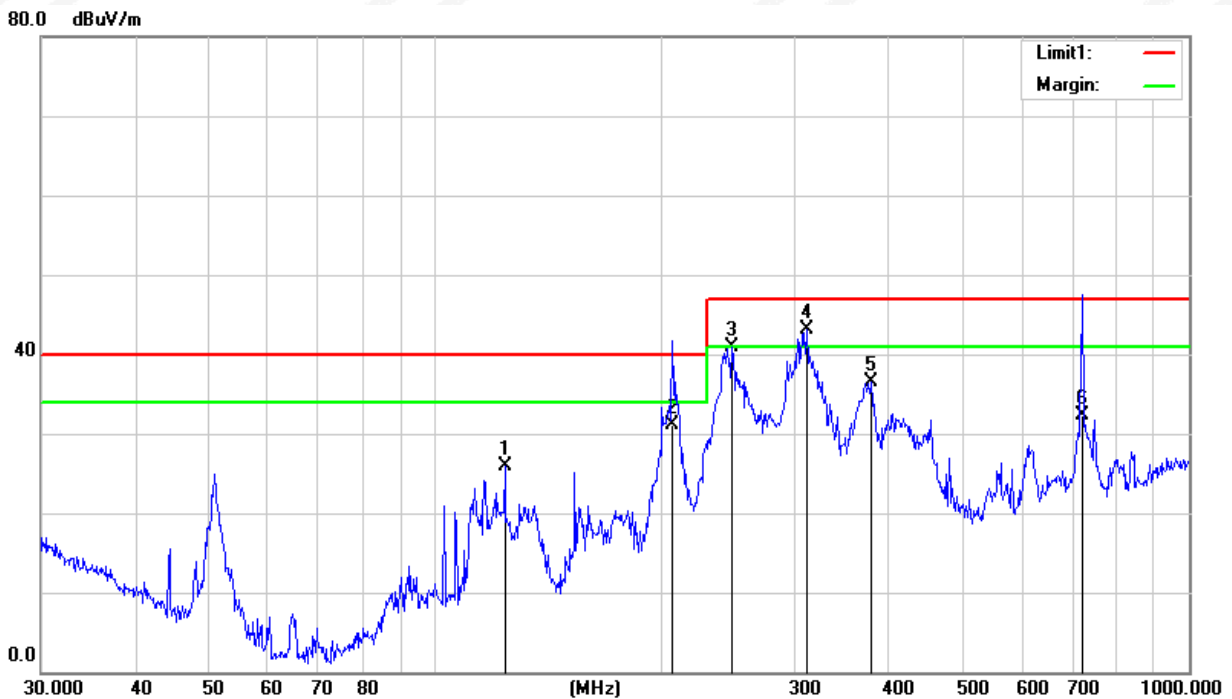
3.2.6 TEST RESULTS

Temperature:	25.3°C	Relative Humidity:	43%
Phase:	Horizontal	Test Mode:	Mode 1
Test Voltage:	DC 5V	Test Date:	2023.09.18

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Results (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	123.6984	44.22	-18.22	26.00	40.00	-14.00	QP
2	206.3175	52.39	-21.22	31.17	40.00	-8.83	QP
3	247.6820	58.72	-17.85	40.87	47.00	-6.13	QP
4	311.0867	58.46	-15.41	43.05	47.00	-3.95	QP
5	378.5842	51.11	-14.60	36.51	47.00	-10.49	QP
6	721.8260	38.75	-6.51	32.24	47.00	-14.76	QP

Remark:

1. All readings are Quasi-Peak
2. Margin = Result (Result = Reading + Factor)–Limit
3. Factor= Cable Loss +Antenna Factor–Amplifier Gain



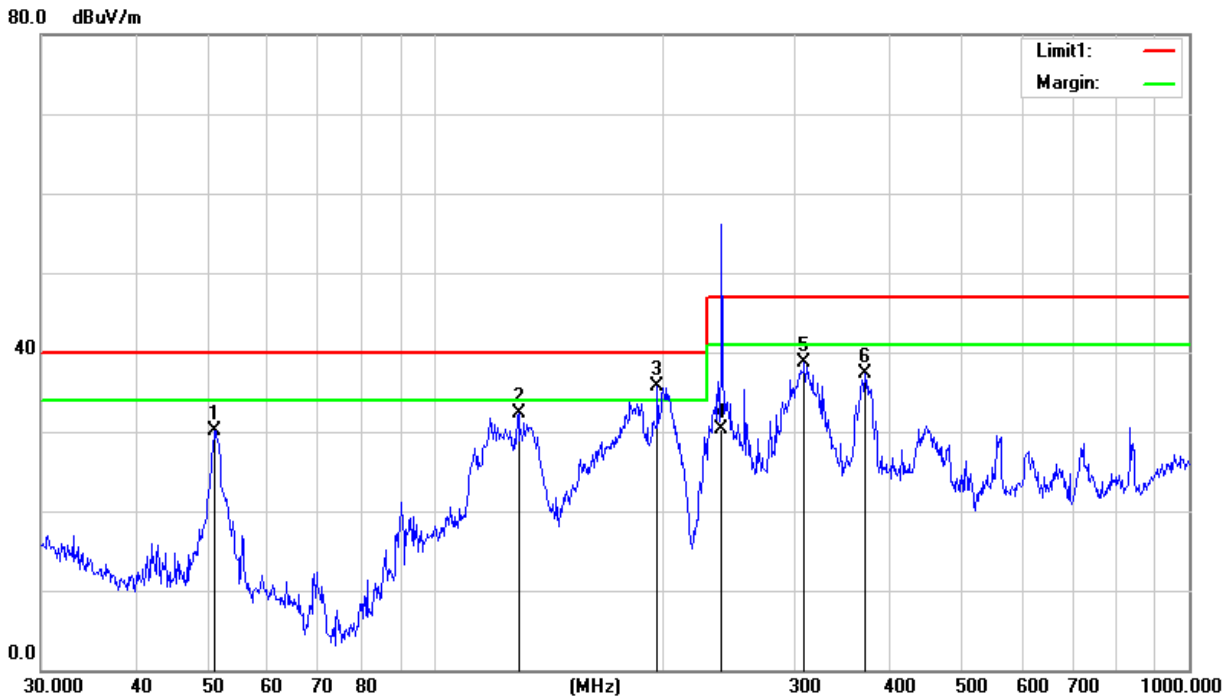


Temperature:	25.3°C	Relative Humidity:	43%
Phase:	Vertical	Test Mode:	Mode 1
Test Voltage:	DC 5V	Test Date:	2023.09.18

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Results (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
1	50.9420	52.23	-22.05	30.18	40.00	-9.82	QP
2	129.0146	50.42	-18.19	32.23	40.00	-7.77	QP
3	197.2000	56.65	-20.96	35.69	40.00	-4.31	QP
4	240.1473	49.44	-19.22	30.22	47.00	-16.78	QP
5	308.9125	54.20	-15.57	38.63	47.00	-8.37	QP
6	372.0045	51.82	-14.46	37.36	47.00	-9.64	QP

Remark:

- 1. All readings are Quasi-Peak
- 2. Margin = Result (Result = Reading + Factor)–Limit
- 3. Factor= Cable Loss +Antenna Factor–Amplifier Gain





3.2.7 TEST RESULT (1000 - 6000 MHz)

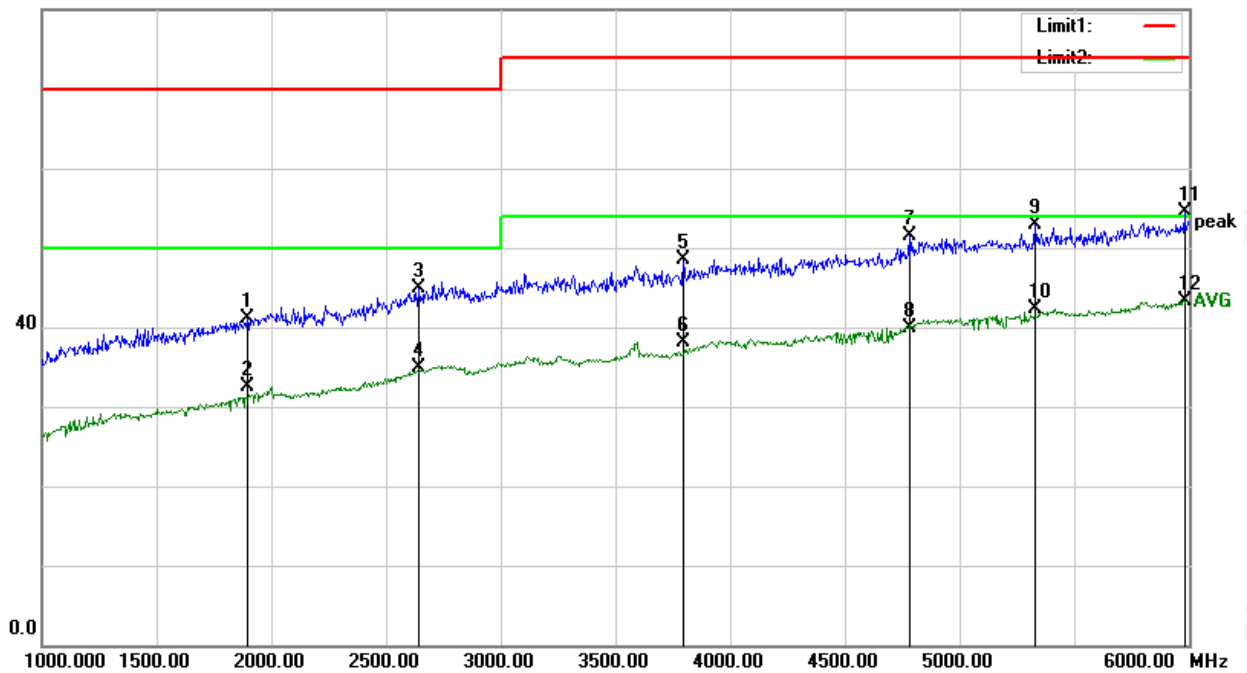
Temperature:	25.3°C	Relative Humidity:	43%
Phase:	Horizontal	Test Mode:	Mode 1
Test Voltage:	DC 5V	Test Date:	2023.08.03

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
1	1895.000	42.49	-1.43	41.06	70.00	-28.94	peak
2	1895.000	33.86	-1.43	32.43	50.00	-17.57	AVG
3	2640.000	44.67	0.18	44.85	70.00	-25.15	peak
4	2640.000	34.70	0.18	34.88	50.00	-15.12	AVG
5	3795.000	44.72	3.83	48.55	74.00	-25.45	peak
6	3795.000	34.27	3.83	38.10	54.00	-15.90	AVG
7	4780.000	46.04	5.40	51.44	74.00	-22.56	peak
8	4780.000	34.54	5.40	39.94	54.00	-14.06	AVG
9	5330.000	46.03	6.96	52.99	74.00	-21.01	peak
10	5330.000	35.26	6.96	42.22	54.00	-11.78	AVG
11	5980.000	47.00	7.57	54.57	74.00	-19.43	peak
12	5980.000	35.77	7.57	43.34	54.00	-10.66	AVG

Remark:

1. All readings are Peak and Average values
2. Margin = Result (Result = Reading + Factor) – Limit
3. Factor = Cable Loss + Antenna Factor - Amplifier Gain

80.0 dBuV/m



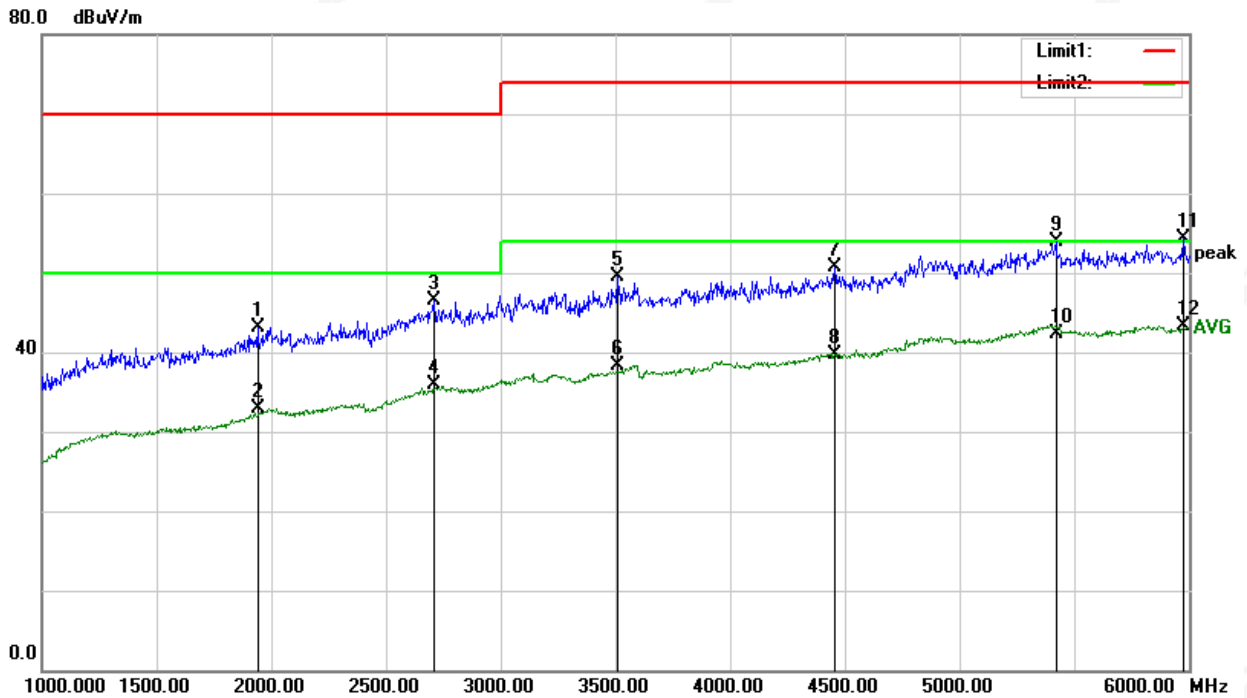


Temperature:	25.3°C	Relative Humidity:	43%
Phase:	Vertical	Test Mode:	Mode 1
Test Voltage:	DC 5V	Test Date:	2023.08.03

No.	Frequency (MHz)	Reading (dBuV)	Correct Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Remark
1	1940.000	44.42	-1.29	43.13	70.00	-26.87	peak
2	1940.000	34.19	-1.29	32.90	50.00	-17.10	AVG
3	2710.000	45.83	0.66	46.49	70.00	-23.51	peak
4	2710.000	35.18	0.66	35.84	50.00	-14.16	AVG
5	3510.000	47.03	2.46	49.49	74.00	-24.51	peak
6	3510.000	35.92	2.46	38.38	54.00	-15.62	AVG
7	4455.000	46.12	4.51	50.63	74.00	-23.37	peak
8	4455.000	35.29	4.51	39.80	54.00	-14.20	AVG
9	5420.000	46.72	7.27	53.99	74.00	-20.01	peak
10	5420.000	34.98	7.27	42.25	54.00	-11.75	AVG
11	5975.000	46.66	7.56	54.22	74.00	-19.78	peak
12	5975.000	35.83	7.56	43.39	54.00	-10.61	AVG

Remark:

- 1. All readings are Peak and Average values
- 2. Margin = Result (Result = Reading + Factor)–Limit
- 3. Factor= Cable Loss +Antenna Factor–Amplifier Gain



3.3 HARMONICS CURRENT

3.3.1 LIMITS OF THE HARMONICS CURRENT

EN 61000-3-2/IEC 61000-3-2					
Equipment Category	Max. Permissible Harmonic Current (in Amperes)	Equipment Category	Harmonic Order n	Max. Permissible Harmonic Current (in A) (mA/w)	
Class A	Same as Limits Specified in 4-2.1, Table - I, but only odd harmonics required	Class D	3	2.30	3.4
			5	1.14	1.9
			7	0.77	1.0
			9	0.40	0.5
			11	0.33	0.35
			13 ≤ n ≤ 39	see Table I	3.85/n
only odd harmonics required					

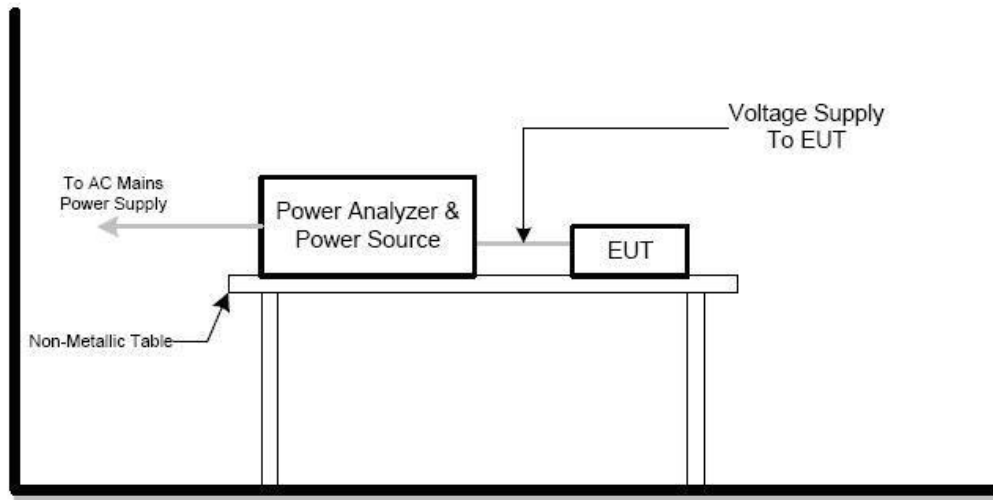
3.3.2 TEST PROCEDURE

- a. The EUT was placed on the top of a wooden table 0.8 meter above the ground and operated to produce the maximum harmonic components under normal operating conditions.
- b. The classification of EUT is according to section 5 of EN IEC 61000-3-2. The EUT is classified as follows:
 - Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.
 - Class B: Portable tools. Portable tools; Arc welding equipment which is not professional equipment.
 - Class C: Lighting equipment.
 - Class D: Equipment having a specified power less than or equal to 600W of the following types: Personal computers and personal computer monitors and television receivers.
- c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

3.3.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** described unless otherwise a special operating condition is specified in the following during the testing.

3.3.4 TEST SETUP





3.3.5 TEST RESULTS

EUT: Smart Phone

Test category: IEC/EN 61000-3-2:2019+A1:2021 Class A

Measurement standard: IEC 61000-4-7 Ed2:1:2009

Test date:2023-09-25

Start time: 14:56:45

Test duration (sec):150

Describe:

Operator: STAR

Model/Type:WP30 Pro

Serial number:

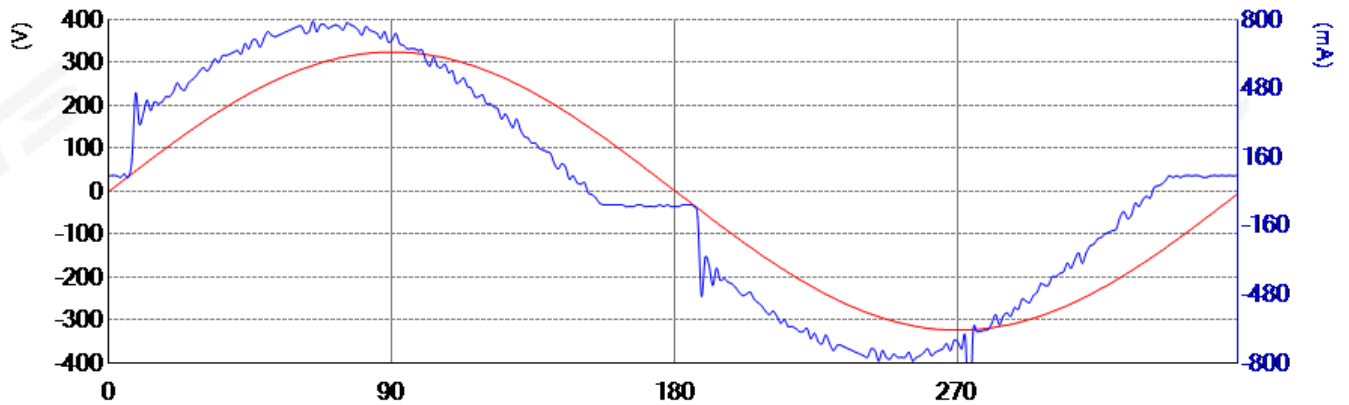
End time: 14:59:21

Test Result: pass

Source qualification(Power Off Load): Idle - Pass

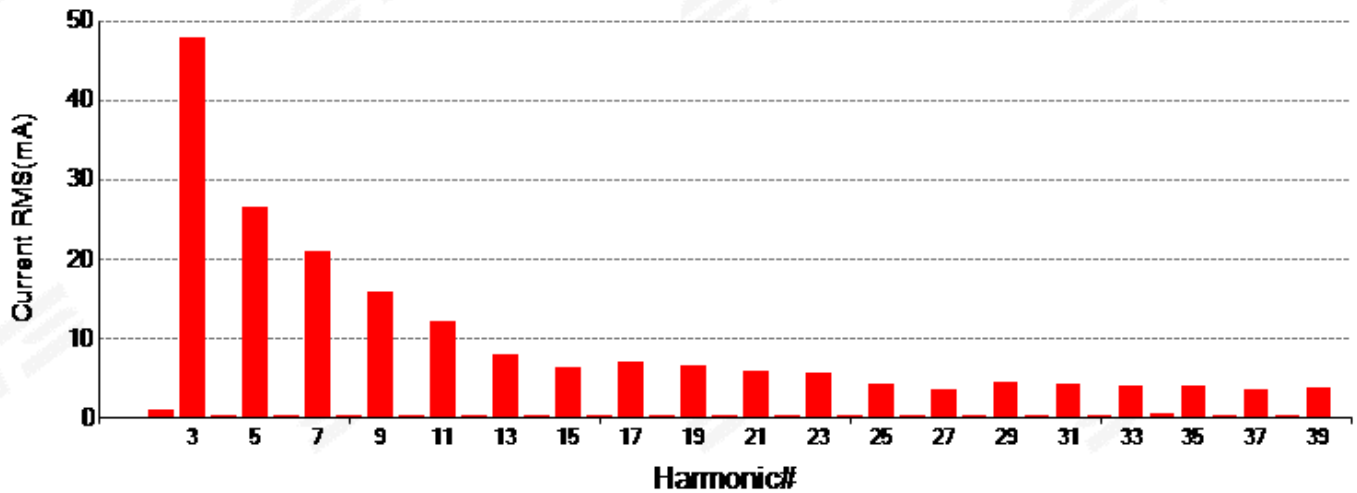
Current & voltage waveforms

Waveform Graph



Harmonics and Class A

Harmonics Histogram





Harmonics Test Summary

EUT: Smart Phone

Test category: IEC/EN 61000-3-2:2019+A1:2021 Class A

Measurement standard: IEC 61000-4-7 Ed2:1:2009

Test date:2023-09-25

Start time: 14:56:45

Test duration (sec):150

Describe:

Operator: STAR

Model/Type:WP30 Pro

Serial number:

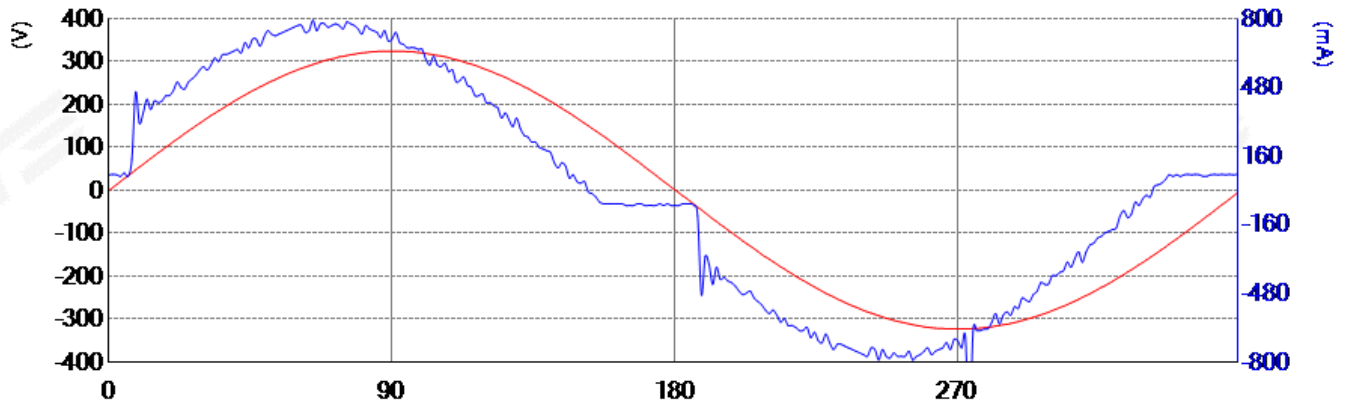
End time: 14:59:21

Test Result: pass

Source qualification(Power Off Load): Idle - Pass

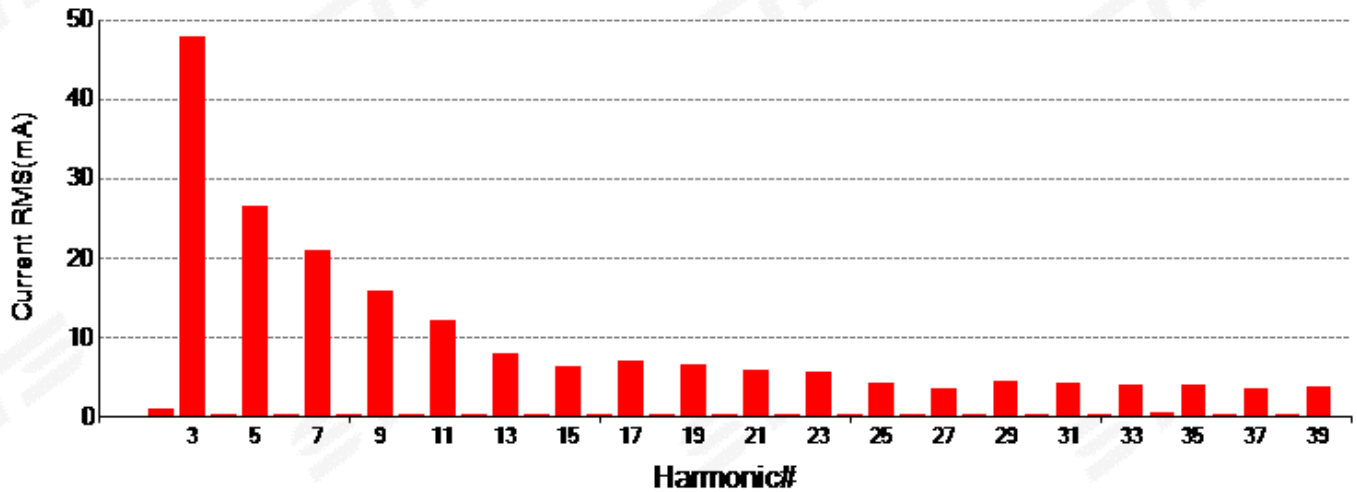
Current & voltage waveforms

Waveform Graph



Harmonics and Class A

Harmonics Histogram



**Harmonics Test Summary**

EUT: Smart Phone

Operator: STAR

Test category: IEC/EN 61000-3-2:2019+A1:2021 Class A

Model/Type:WP30 Pro

Measurement standard: IEC 61000-4-7 Ed2:1:2009

Serial number:

Test date:2023-09-25

Start time: 14:56:45

End time: 14:59:21

Test duration (sec):150

Describe:

Test Result: pass

Source qualification(Power Off Load): Idle - Pass

THC(mA): 64.780

I - THD(%): 13.5

POHC(mA):13.800

POHC Limit(mA):251.353

Parameter values during test:

V_RMS (Volts): 230.2

Frequency(Hz): 50.0

I_RMS(mA): 495.4

Crest Factor: 1.473

Power (Watts): 106.3

Power Factor: 0.932

Harm#	Harms(filtered) (mA)	Limit (mA)	Harms(avg) (mA)	100%Limit	Harms(max) (mA)	150%Limit	Status
I_Fund	478.600						
2	0.920	1080.000	0.700	0.065	1.340	0.083	Pass
3	47.760	2300.000	46.900	2.039	47.810	1.386	Pass
4	0.200	430.000	0.100	0.023	0.310	0.048	Pass
5	26.410	1140.000	26.600	2.333	26.790	1.567	Pass
6	0.200	300.000	0.100	0.033	0.260	0.058	Pass
7	20.880	770.000	21.400	2.779	21.620	1.872	Pass
8	0.200	230.000	0.100	0.043	0.400	0.116	Pass
9	15.820	400.000	15.800	3.950	15.980	2.663	Pass
10	0.200	184.000	0.100	0.054	0.200	0.072	Pass
11	12.160	330.000	11.500	3.485	12.180	2.461	Pass
12	0.170	153.300	0.100	0.065	0.310	0.135	Pass
13	7.880	210.000	7.900	3.762	8.180	2.597	Pass
14	0.170	131.400	0.100	0.076	0.170	0.086	Pass
15	6.330	150.000	6.600	4.400	6.760	3.004	Pass
16	0.220	115.000	0.100	0.087	0.330	0.191	Pass
17	6.900	132.400	6.900	5.211	6.940	3.494	Pass
18	0.110	102.200	0.100	0.098	0.220	0.144	Pass
19	6.420	118.400	7.000	5.912	7.320	4.122	Pass
20	0.260	92.000	0.100	0.109	0.380	0.275	Pass
21	5.820	107.100	6.000	5.602	6.290	3.915	Pass
22	0.170	83.600	0.100	0.120	0.260	0.207	Pass
23	5.550	97.800	5.100	5.215	5.610	3.824	Pass
24	0.220	76.700	0.100	0.130	0.260	0.226	Pass
25	4.110	90.000	4.100	4.556	4.200	3.111	Pass
26	0.200	70.800	0.100	0.141	0.400	0.377	Pass
27	3.590	83.300	3.600	4.322	3.700	2.961	Pass
28	0.200	65.700	0.100	0.152	0.220	0.223	Pass
29	4.450	77.600	4.100	5.284	4.490	3.857	Pass
30	0.220	61.300	0.200	0.326	0.380	0.413	Pass
31	4.180	72.600	4.400	6.061	4.580	4.206	Pass
32	0.170	57.500	0.100	0.174	0.240	0.278	Pass
33	4.040	68.200	4.200	6.158	4.380	4.282	Pass
34	0.380	54.100	0.200	0.370	0.420	0.518	Pass
35	4.060	64.300	3.700	5.754	4.090	4.241	Pass
36	0.130	51.100	0.100	0.196	0.240	0.313	Pass
37	3.500	60.800	3.900	6.414	4.090	4.485	Pass
38	0.350	48.400	0.200	0.413	0.400	0.551	Pass
39	3.610	57.700	3.900	6.759	4.020	4.645	Pass
40	0.240	46.000	0.200	0.435	0.290	0.420	Pass

Note: All harmonics are below the minimum limits and are ignored.

**Power Supply Quality Data**

EUT: Smart Phone

Test category: IEC/EN 61000-3-2:2019+A1:2021 Class A

Measurement standard: IEC 61000-4-7 Ed2:1:2009

Test date:2023-09-25

Start time: 14:56:45

Test duration (sec):150

Describe:

Source qualification(Power Off Load): Pass

Measurements are compliant with IEC/EN61000-3-2 Ed. 4 & IEC/EN61000-4-7 Ed. 2.1

Operator: STAR

Model/Type:WP30 Pro

Serial number:

End time: 14:59:21

	Nominal	Measured		Deviation	Allowed Deviation	Result
		Low	High			
Supply Voltage	230	230.16	230.18	0.18	4.6	Pass
Supply Frequency	50	50.0	50.0	0.0	0.25	Pass
Crest Phase	90.0	90.7	91.2	1.2	87 - 93	N/A
Crest Factor	1.414	1.412	1.412	0.002	1.40 - 1.42	N/A
Fundamental Voltage	230.16	-	-	-	-	-

Harm#	Harmonics Voltage	Harmonic Ratio	Limit	Result
2	0.000	0.000	0.200	Pass
3	0.020	0.010	0.900	Pass
4	0.000	0.001	0.200	Pass
5	0.100	0.050	0.400	Pass
6	0.010	0.005	0.200	Pass
7	0.080	0.039	0.300	Pass
8	0.000	0.000	0.200	Pass
9	0.020	0.013	0.200	Pass
10	0.000	0.001	0.100	Pass
11	0.040	0.021	0.100	Pass
12	0.010	0.005	0.100	Pass
13	0.010	0.005	0.100	Pass
14	0.000	0.005	0.100	Pass
15	0.040	0.021	0.100	Pass
16	0.000	0.000	0.100	Pass
17	0.010	0.005	0.100	Pass
18	0.010	0.003	0.100	Pass
19	0.040	0.021	0.100	Pass
20	0.000	0.000	0.100	Pass
21	0.030	0.016	0.100	Pass
22	0.000	0.000	0.100	Pass
23	0.010	0.010	0.100	Pass
24	0.000	0.000	0.100	Pass
25	0.020	0.013	0.100	Pass
26	0.010	0.005	0.100	Pass
27	0.040	0.021	0.100	Pass
28	0.000	0.000	0.100	Pass
29	0.010	0.005	0.100	Pass
30	0.000	0.000	0.100	Pass
31	0.020	0.010	0.100	Pass
32	0.000	0.000	0.100	Pass
33	0.010	0.008	0.100	Pass
34	0.000	0.000	0.100	Pass
35	0.010	0.010	0.100	Pass
36	0.000	0.000	0.100	Pass
37	0.040	0.021	0.100	Pass
38	0.000	0.000	0.100	Pass
39	0.050	0.031	0.100	Pass
40	0.000	0.000	0.100	Pass

3.4 VOLTAGE FLUCTUATION AND FLICKERS

3.4.1 LIMITS OF THE VOLTAGE FLUCTUATION AND FLICKERS

Tests	Limit	Descriptions
	IEC/EN 61000-3-3	
P _{st}	≤ 1.0, T _p = 10 min.	Short Term Flicker Indicator
P _{lt}	≤0.65, T _p =2 hr.	Long Term Flicker Indicator
T _{dt(s)}	≤ 3.3%	Relative Steady-State V-Chang
d _{max} (%)	≤ 4%	Maximum Relative V-Chang
d _c (%)	≤ 3.3% for > 500ms	Relative V-change Characteristic

3.4.2 TEST PROCEDURE

a. Fluctuation and Flickers Test:

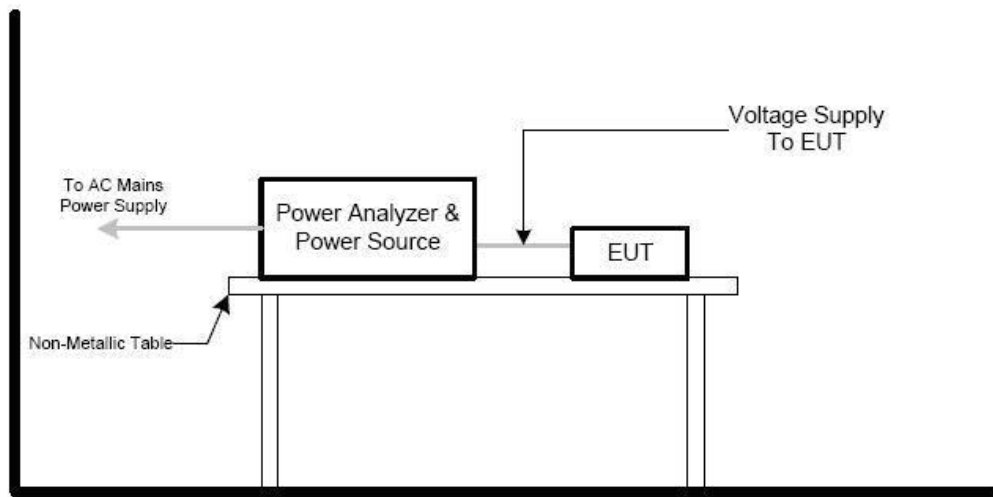
Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in Clause 6.0/4.0 of IEC/EN 61000-3-3 depend.

b. All types of voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.3 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 described unless otherwise a special operating condition is specified in the following during the testing.

3.4.4 TEST SETUP





3.4.5 TEST RESULTS

EUT: Smart Phone

Operator: STAR

Test category: IEC 61000-3-3 Ed3.1:2017

Model/Type:WP30 Pro

Measurement standard: IEC 61000-15 Ed2.0:2010

Serial number:

Test date:2023-08-07

Start time: 09:16:51

End time: 09:26:51

Test duration (sec):600

Describe:

Load Power :112.700 W

Power Factor:0.939

Load Current : 0.244 mArms

Crest Factor:4.082

Nominal Voltage : 229.99 Vrms

Test Result: pass

Status: Test Completed

Psti and limit line

European Limits



Result:

T-max (ms):	0.00	Test limit (ms):	500.00	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.00	Test limit:	1.00	Pass

4. EMC IMMUNITY TEST

4.1 STANDARD COMPLIANCE/SERVIRITY LEVEL/CRITERIA

Tests Standard No.	TEST SPECIFICATION	Test Mode Test Ports	Perform. Criteria
1. ESD IEC/EN 61000-4-2	8KV air discharge 4KV contact discharge	Direct Mode	B
	4KV HCP discharge 4KV VCP discharge	Indirect Mode	B
2. RS IEC/EN 61000-4-3	80 MHz - 1000 MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz, 1000Hz, 80%, AM modulated	Enclosure	A
3. EFT/Burst IEC/EN 61000-4-4	5/50ns Tr/Th 5KHz Repetition Freq.	Power Supply Port	B
	5/50ns Tr/Th 5KHz Repetition Freq.	CTL/Signal Data Line Port	B
4. Surges IEC/EN 61000-4-5	1.2/50(8/20) Tr/Th us	L-N	B
	1.2/50(8/20) Tr/Th us	L-PE N-PE	B
5. Injected Current IEC/EN 61000-4-6	0.15 MHz to 80 MHz, 1000Hz 80 % , AM Modulated 150Ω source impedance	CTL/Signal Port	A
	0.15 MHz to 80 MHz, 1000Hz 80 % , AM Modulated 150Ω source impedance	AC Power Port	A
	0.15 MHz to 80 MHz, 1000Hz 80 % , AM Modulated 150Ω source impedance	DC Power Port	A
6. Power Frequency Magnetic Field IEC/EN 61000-4-8	50 Hz,	Enclosure	A
7. Volt. Interruptions Volt. Dips IEC/EN 61000-4-11	Voltage dip 100%	AC Power Port	B
	Voltage dip 30%		C
	Interruption 100%		C

4.2 GENERAL PERFORMANCE CRITERIA

According to **EN 55035** standard, the general performance criteria are as follows:

Criterion A	The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B	During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test. After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

4.2.1 GENERAL PERFORMANCE CRITERIA TEST SETUP

The EUT tested system was configured as the statements of **2.2** or **2.3** unless otherwise a special operating condition is specified in the following during the testing.

4.3 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

4.3.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Required Performance:	B
Discharge Voltage:	Air Discharge : 2KV/4KV/8KV (Direct) Contact Discharge : 4KV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: at least 10 times on each point Contact Discharge: at least 10 times on each point 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

4.3.2 TEST PROCEDURE

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manners:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation
The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.

The time interval between two successive single discharges was at least 1 second.

The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meter from the EUT.

Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.

Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.

Vertical Coupling Plane (VCP):

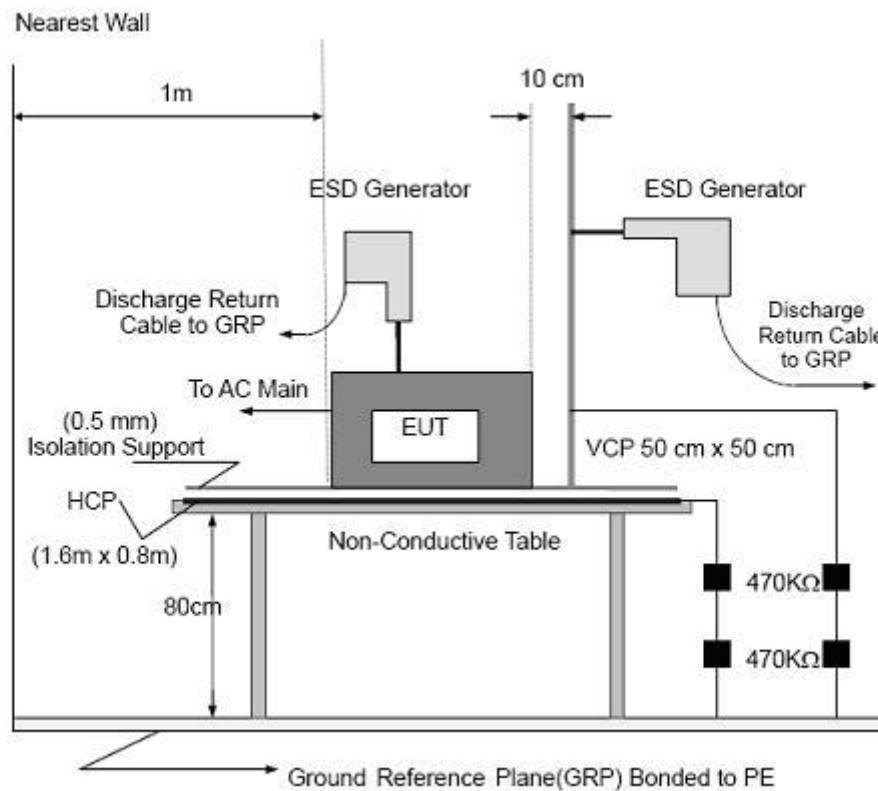
The coupling plane of dimensions 0.5m x 0.5m, is placed parallel to and positioned at a distance 0.1m from the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

- b. Air discharges at insulation surfaces of the EUT.
It was at least ten single discharges with positive and negative at the same selected point.

4.3.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meter high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940kΩ total impedance. The equipment under test was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of 0.8-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1 meter thickness. The GRP was consisted of a sheet of aluminum that is at least 0.25mm thick, and extended at least 0.5 meter from the EUT on all sides.



4.3.4 TEST RESULTS

Temperature:	25.0°C	Relative Humidity:	49%
Pressure:	1017.8hPa	Test Voltage:	AC 230V/50Hz DC 8.8V
Test Mode:	Mode 1/2/3	Test Date:	2023.09.19

Discharge Level/KV	Polarity	Test Points	Contact Discharge	Air Discharge	Criterion	Test Result
2,4	+/-	HCP/VCP	Note1	NA	B	A
2,4	+/-	Green Dot	Note1	NA	B	B
2,4,8	+/-	Red Dot	NA	Note1	B	A

Note1 : The EUT function was correct during the test.

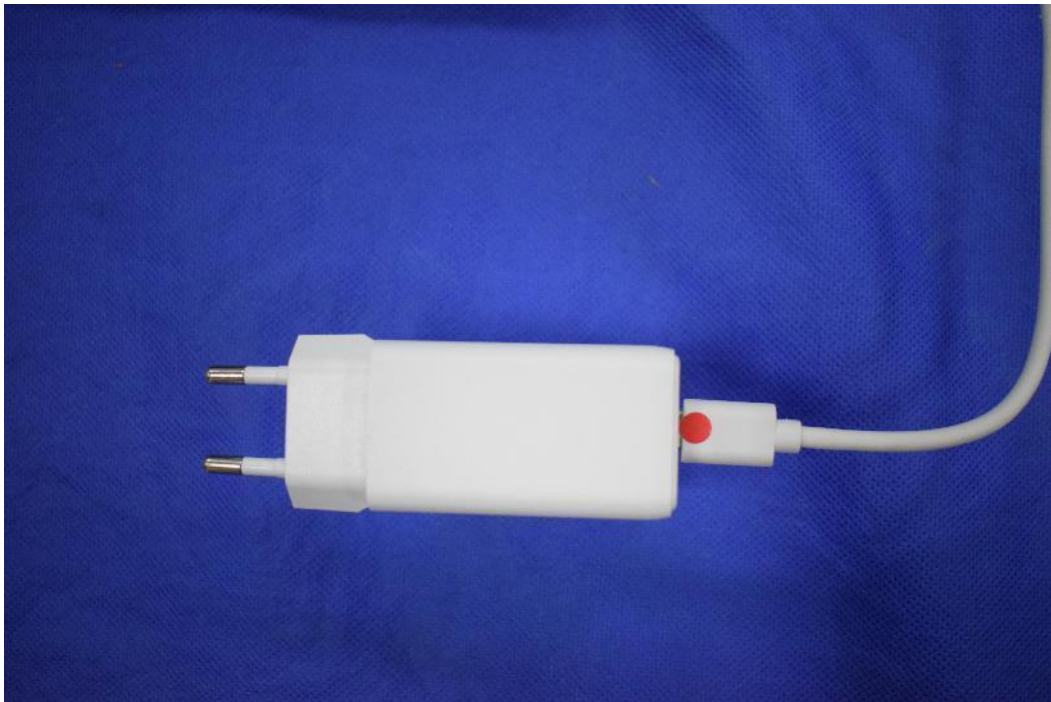
Note2 : Red Dot —Air Discharged

Green Dot —Contact Discharged

The Photo for Discharge Points of EUT







4.4 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

4.4.1 TEST SPECIFICATION

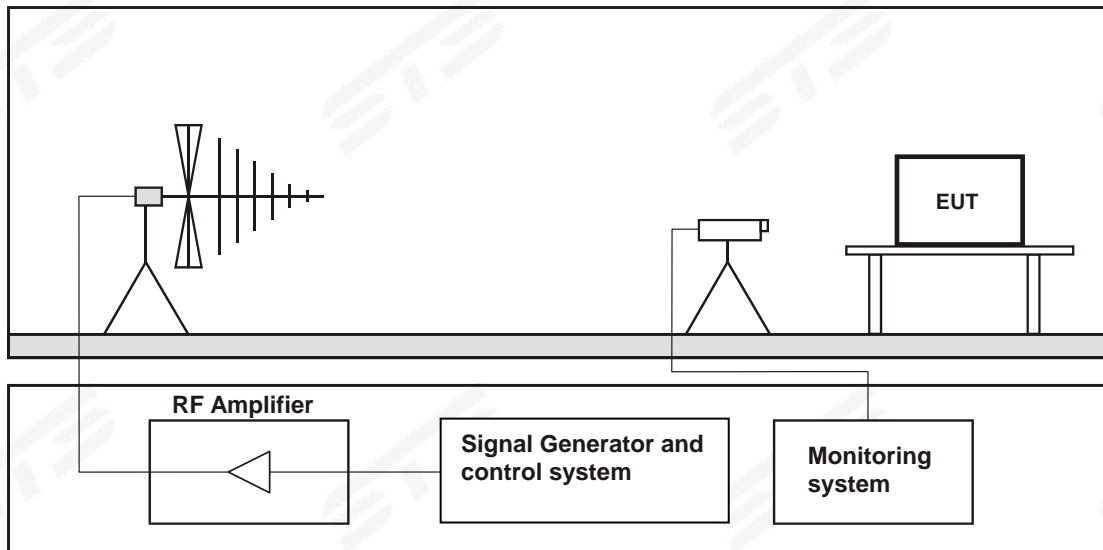
Basic Standard:	IEC/EN 61000-4-3
Required Performance:	A
Test Frequency Range:	80 MHz-1000 MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz
Primary Function Of Telephony Test Frequencies:	80 MHz; 120 MHz; 160 MHz; 230 MHz; 434 MHz; 460 MHz; 600 MHz; 863 MHz and 900 MHz
Field Strength:	3 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Dwell Time:	3s

4.4.2 TEST PROCEDURE

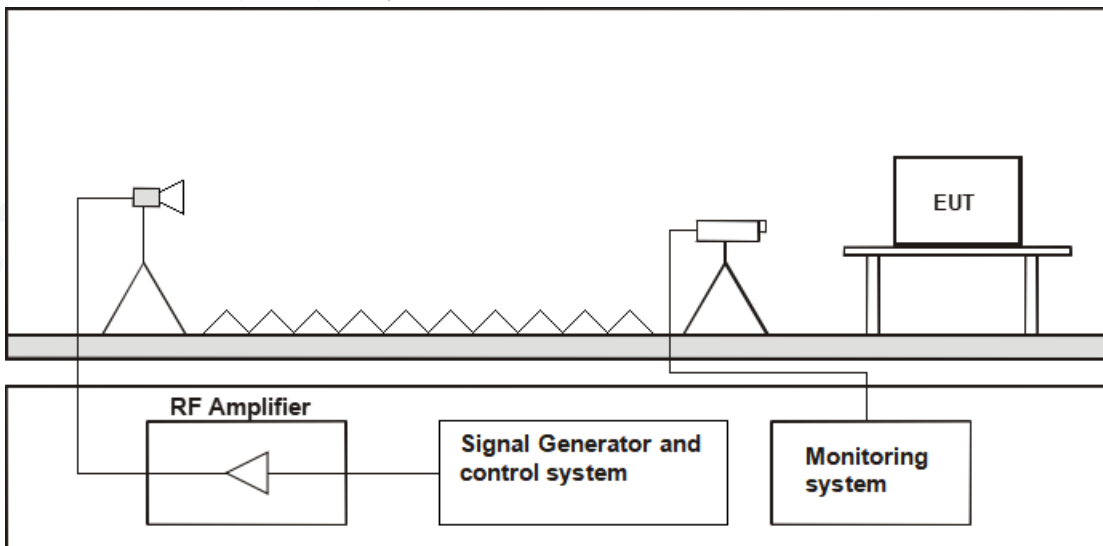
- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The frequency range is swept from 80 MHz to 1000 MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz, with the signal 80% amplitude modulated with a 1kHz sine-wave. The rate of sweep did not exceed 3s, where the frequency range is swept incrementally, the step size was 1% of preceding frequency value.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

4.4.3 TEST SETUP

(A) RS Test Set-Up Frequency Below 1GHz



(B) RS Test Set-Up Frequency Above 1GHz



Note:

TABLE-TOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive table 0.8 meter in height. The system under test was connected to the power and signal wire according to the relevant installation instructions.

FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC/EN 61000-4-3 was placed on a non-conductive wood support 0.1 meter in height. The system under test was connected to the power and signal wire according to the relevant installation instructions.

**4.4.4 TEST RESULTS**

Temperature:	24.4°C	Relative Humidity:	50%
Test Voltage:	AC 230V/50Hz DC 8.87V	Test Date:	2023.08.07
Test Mode:	Mode 1/2		

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform. Criteria	Results	Judgement
80MHz - 1000MHz	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	A	A	PASS
			Rear			
			Left			
			Right			
1800MHz	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	A	A	PASS
			Rear			
			Left			
			Right			
2600MHz	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	A	A	PASS
			Rear			
			Left			
			Right			
3500MHz	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	A	A	PASS
			Rear			
			Left			
			Right			
5000MHz	H / V	3 V/m (rms) AM Modulated 1000Hz, 80%	Front	A	A	PASS
			Rear			
			Left			
			Right			

4.5 ELECTRICAL FAST TRANSIENT (EFT)

4.5.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-4
Required Performance:	B
Test Voltage:	Power Line: 1 KV Signal/Control Line: 0.5 KV DC network power port: 0.5 KV
Polarity:	Positive & Negative
Impulse Frequency:	5 kHz
Impulse Wave shape :	5/50 ns
Burst Duration:	15ms
Burst Period:	300ms
Test Duration:	Not less than 1 min

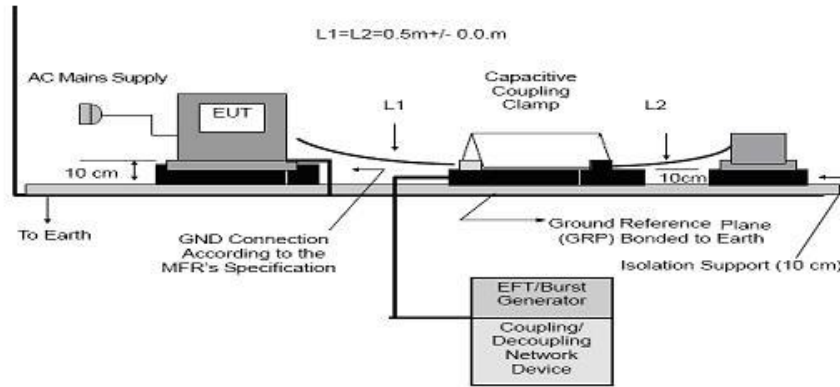
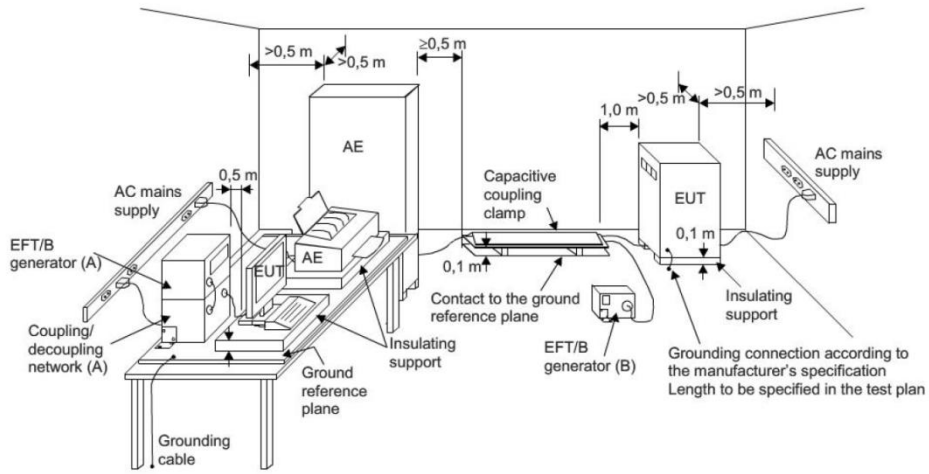
4.5.2 TEST PROCEDURE

The ground reference plane shall be a metallic sheet (copper or aluminum) of 0.25 mm minimum thickness; other metallic materials may be used, but they shall have at least 0.65 mm minimum thickness.

The other conditions required in the following manners:

- a. The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minutes.

4.5.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

- a. Table-top equipment and equipment normally mounted on ceilings or walls as well as built-in equipment shall be tested with the EUT located (0.1 ± 0.01) m above the ground reference plane.
- b. Testing of large table-top equipment or multiple systems can be performed on the floor; maintaining the same distances as for the test setup of table-top equipment.
- c. The test generator and the coupling/decoupling network shall be bonded to the ground reference plane.
- d. The ground reference plane shall be a metallic sheet (copper or aluminum) of 0.25mm minimum thickness; other metallic materials may be used, but they shall have at least 0.65 mm minimum thickness.
- e. The minimum size of the ground reference plane is 0.8m x 1m. The actual size depends on the dimension of the EUT.
- f. The ground reference plane shall project beyond the EUT by at least 0.1m on all sides.
- g. The ground reference plane shall be connected to the earth (PE) for safety reasons.
- h. The EUT shall be arranged and connected to satisfy its functional requirements according to the equipment installation specifications.
- i. The minimum distance between the EUT and all other conductive structures (including the generator, AE and the walls of a shielded room), except the ground reference plane, shall be more than 0.5m.
- j. All cables to the EUT shall be placed on the insulation support 0.1m above the ground reference plane. Cables not subject to electrical fast transients shall be routed as far as possible from the cable under test to minimize the coupling between the cables.
- k. The EUT shall be connected to the earth system in accordance with the manufacturer's installation specifications; no additional earth connections are allowed.
- l. The connection impedance of the coupling/decoupling network earth cables to the ground reference plane and all connectors shall provide a low inductance.
- m. Either a direct coupling network or a capacitive clamp shall be used for the application of the test voltages. The test voltages shall be coupled to all of the EUT ports in turn including those between two units of equipment involved in the test, unless the length of the interconnecting cable makes it impossible to test.

FLOOR-STANDING EQUIPMENT

When using the coupling clamp, the minimum distance between the coupling plates and all other conductive surfaces (including the generator), except the ground reference plane beneath the coupling clamp and beneath the EUT, shall be at least 0.5m.

The distance between any coupling devices and the EUT shall be ($0.5 - 0/+0.1$) m for tabletop equipment testing, and (1.0 ± 0.1) m for floor standing equipment, unless otherwise specified in product standards. When it is not physically possible to apply the distances mentioned above, other distances can be used and shall be recorded in the test report.

The cable between the EUT and the coupling device, if detachable, shall be as short as possible to comply with the requirements of this clause. If the manufacturer provides a cable exceeding the distance between the coupling device and the point of entry of the EUT, the excess length of this cable shall be bundled and situated at a distance of 0.1m above the ground reference plane. When a capacitive clamp is used as a coupling device, the excess cable length shall be bundled at the AE side.

Parts of the EUT with interconnecting cables of a length less than 3m, which are not tested, shall be placed on the insulating support. The parts of the EUT shall have a distance of 0.5m between them. Excess cable length shall be bundled.

**4.5.4 TEST RESULTS**

Temperature:	25.4°C	Relative Humidity:	50%
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.07
Test Mode:	Mode 1/2/3		

Coupling Line		Test level	Perform. Criteria	Results	Judgement
AC line	L	±1KV	B	A	PASS
	N	±1KV		A	PASS
	PE	N/A		N/A	N/A
	L+N	±1KV		A	PASS
	L+PE	N/A		N/A	N/A
	N+PE	N/A		N/A	N/A
	L+N+PE	N/A		N/A	N/A
DC network power port Line		N/A		N/A	N/A
Signal Line		N/A		N/A	N/A

Note: 1) N/A - denotes test is not applicable in this test report.

4.6 SURGE TESTING

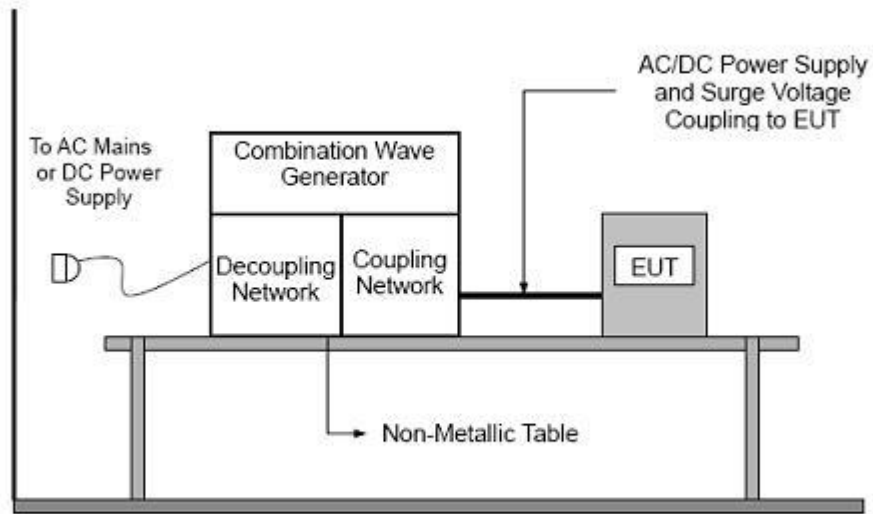
4.6.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-5
Required Performance:	B
Wave-Shape:	Combination Wave 1.2/50us Open Circuit Voltage
Test Voltage:	Power line ~ line to line: 1 KV line to ground: 2 KV Telecommunication line: 0.5 KV DC network power port: 0.5 KV
Surge Input/Output:	L-N, L-PE, N-PE
Generator Source:	(L-N)2 ohm between networks
Impedance:	(L-PE, N-PE)12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0°/90°/180°/270°
Pulse Repetition Rate:	1 time / min. (maximum)
Number of Tests:	5 positive and 5 negative at selected points

4.6.2 TEST PROCEDURE

- a. For EUT power supply:
The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meter in length (or shorter).
- b. For test applied to unshielded unsymmetrical operated interconnection lines of EUT:
The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meter in length (or shorter).

4.6.3 TEST SETUP





4.6.4 TEST RESULTS

Temperature:	24.4°C	Relative Humidity:	54%
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.07
Test Mode:	Mode 1/2/3		

Coupling Line			Test level								Criterion	Result
			0.5 KV		1 KV		2 KV		4 KV			
			+	-	+	-	+	-	+	-		
AC line	L-N	0°			A	A					B	PASS
		90°			A	A						
		180°			A	A						
		270°			A	A						
	L-PE	0°										
		90°										
		180°										
		270°										
	N-PE	0°										
		90°										
		180°										
		270°										
Signal Line	Line-Line											
	Line-Ground											
DC Line												

Note: 1) N/A - denotes test is not applicable in this test report.

4.7 CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

4.7.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-6
Required Performance:	A
Test Frequency Range:	0.15 MHz-80 MHz
Primary Function Of Telephony Test Frequencies:	0.2 MHz; 1 MHz; 7.1 MHz; 13.56 MHz; 21 MHz; 27.12 MHz and 40.68 MHz
Field Strength:	0.15 MHz - 10 MHz, 3V 10 MHz - 30 MHz, 3V to 1V 30 MHz - 80 MHz, 1V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Dwell Time:	3s

4.7.2 TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.

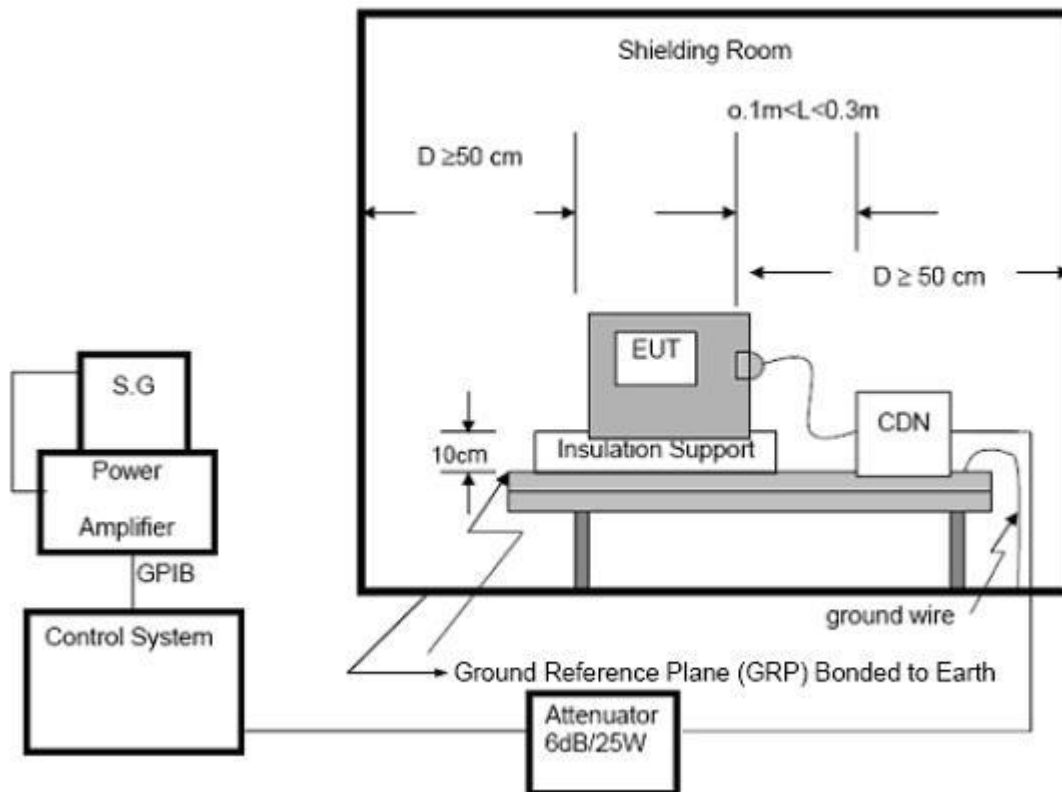
The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.

The frequency range was swept from 150 kHz to 10 MHz, 10 MHz to 30 MHz, 30 MHz to 80 MHz using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was 3s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value from 150 kHz to 80MHz.

The dwell time at each frequency was less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequency (ies) and harmonics or frequencies of dominant interest, was analyzed separately.

Attempts were made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

4.7.3 TEST SETUP



NOTE:

FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meter height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meter and 0.3 meter from the projected geometry of the EUT on the ground reference plane.

4.7.4 TEST RESULTS

Temperature:	24.4°C	Relative Humidity:	50%
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.07
Test Mode:	Mode 1/2		

Test Ports (Mode)	Freq. Range MHz)	Field Strength	Perform. Criteria	Results	Judgement
Input/ Output AC. Power Port	0.15 - 10	3V(rms) AM Modulated 1000Hz, 80%	A	A	PASS
	10 - 30	3V to 1V(rms) AM Modulated 1000Hz, 80%			
	30 - 80	1V(rms) AM Modulated 1000Hz, 80%			
Input/ Output DC. Power Port	0.15 - 10	3V(rms) AM Modulated 1000Hz, 80%	N/A	N/A	N/A
	10 - 30	3V to 1V(rms) AM Modulated 1000Hz, 80%			
	30 - 80	1V(rms) AM Modulated 1000Hz, 80%			
Signal Line	0.15 - 10	3V(rms) AM Modulated 1000Hz, 80%	N/A	N/A	N/A
	10 - 30	3V to 1V(rms) AM Modulated 1000Hz, 80%			
	30 - 80	1V(rms) AM Modulated 1000Hz, 80%			

Note: 1) N/A - denotes test is not applicable in this test report.

4.8 POWER FREQUENCY MAGNETIC FIELD TESTING

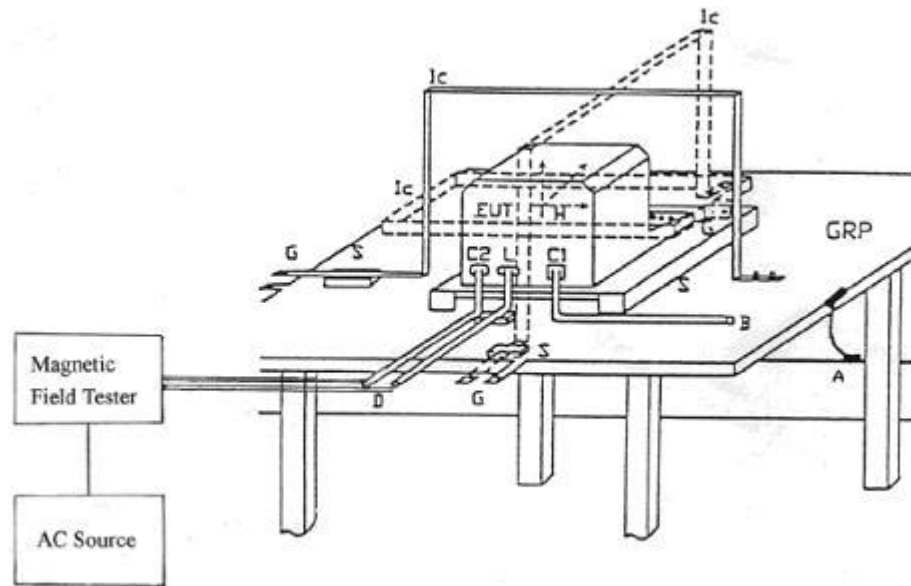
4.8.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-8
Required Performance:	A
Frequency Range:	50Hz
Field Strength:	1 A/m
Observation Time:	5 minute
Inductance Coil:	Rectangular type, 1mx1m

4.8.2 TEST PROCEDURE

- a. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- b. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

4.8.3 TEST SETUP



Note:

TABLE-TOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

**4.8.4 TEST RESULTS**

Temperature:	24.4°C	Relative Humidity:	50%
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.07
Test Mode:	Mode 1/2/3		

Test Mode	Test Level	inductive coil	Duration (s)	Perform Criteria	Results	Judgement
Enclosure	1A/m	X	300	A	A	PASS
Enclosure	1A/m	Y	300	A	A	PASS
Enclosure	1A/m	Z	300	A	A	PASS

4.9 VOLTAGE INTERRUPTION/DIPS TESTING (DIPS)

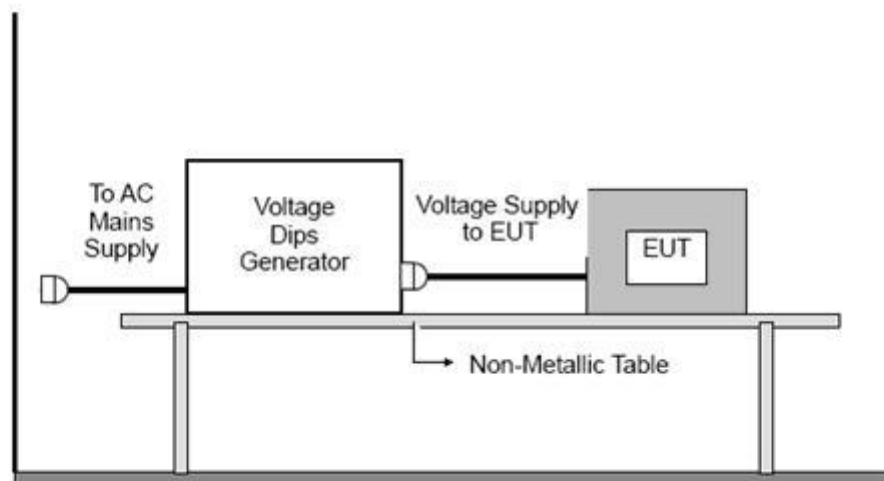
4.9.1 TEST SPECIFICATION

Basic Standard:	IEC/EN 61000-4-11
Required Performance:	B (For 100% Voltage Dips, 0.5 Cycle) C (For 30% Voltage Dips, 25 Cycles) C (For 100% Voltage Interruptions, 250 Cycles)
Test Duration Time:	Minimum 3 test events in sequence
Interval between Event:	Minimum 10 seconds
Phase Angle:	0°/45°/90°/135°/180°/225°/270°/315°/360°
Test Cycle:	3 times

4.9.2 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

4.9.3 TEST SETUP



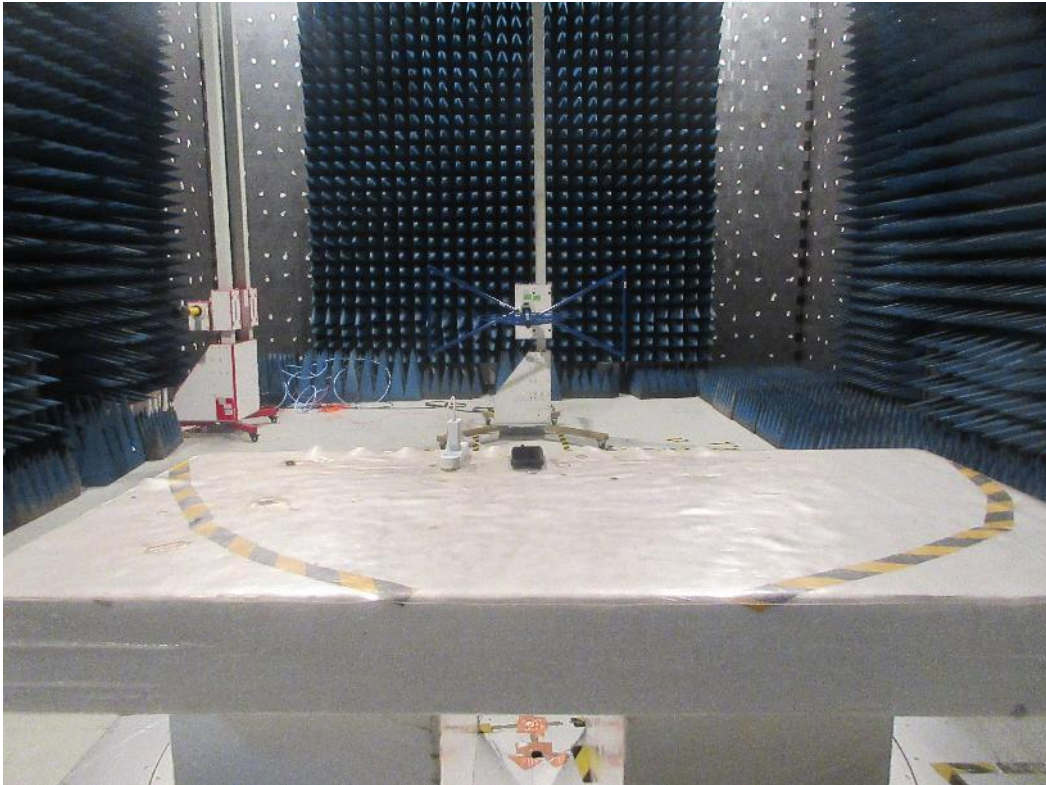
**4.9.4 TEST RESULTS**

Temperature:	24.4°C	Relative Humidity:	50%
Test Voltage:	AC 230V/50Hz	Test Date:	2023.08.07
Test Mode:	Mode 1/2/3		

Voltage Reduction	Duration (ms)	Perform Criteria	Results	Judgement
Interruption 0%	0.5	B	A	PASS
Voltage dip 70%	25	C	A	PASS
Interruption 0%	250	C	B	PASS

APPENDIX 1 - TEST SETUP

RE (30 - 1000 MHz)



RE (1000 - 6000 MHz)



CE



Harmonic&Flick



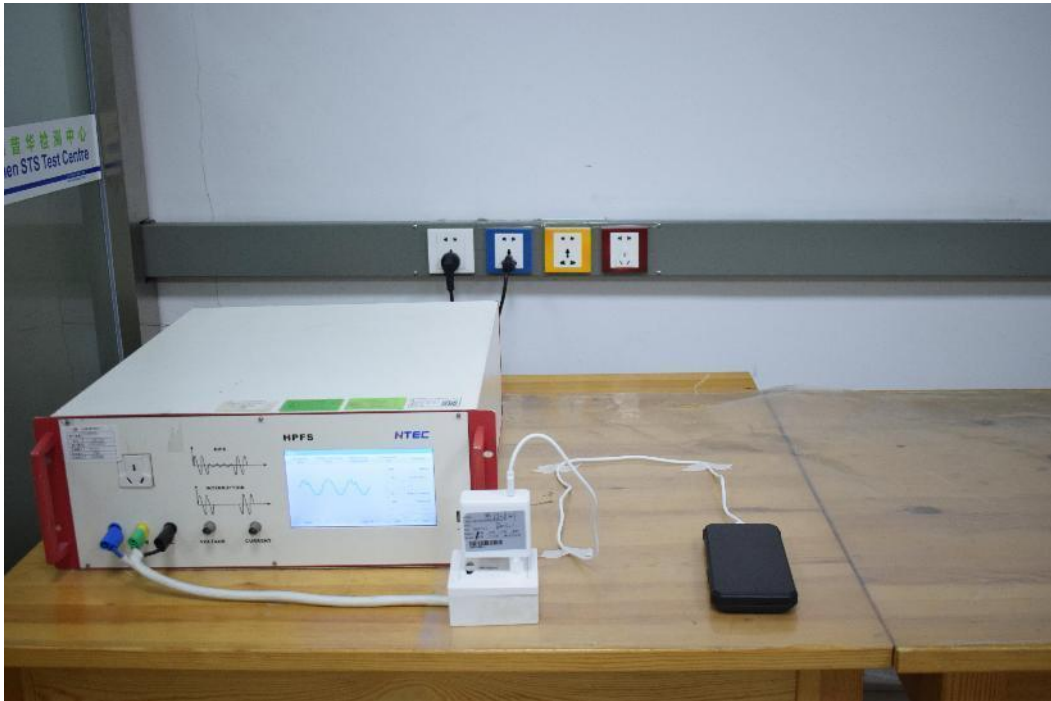
SURGE



EFT



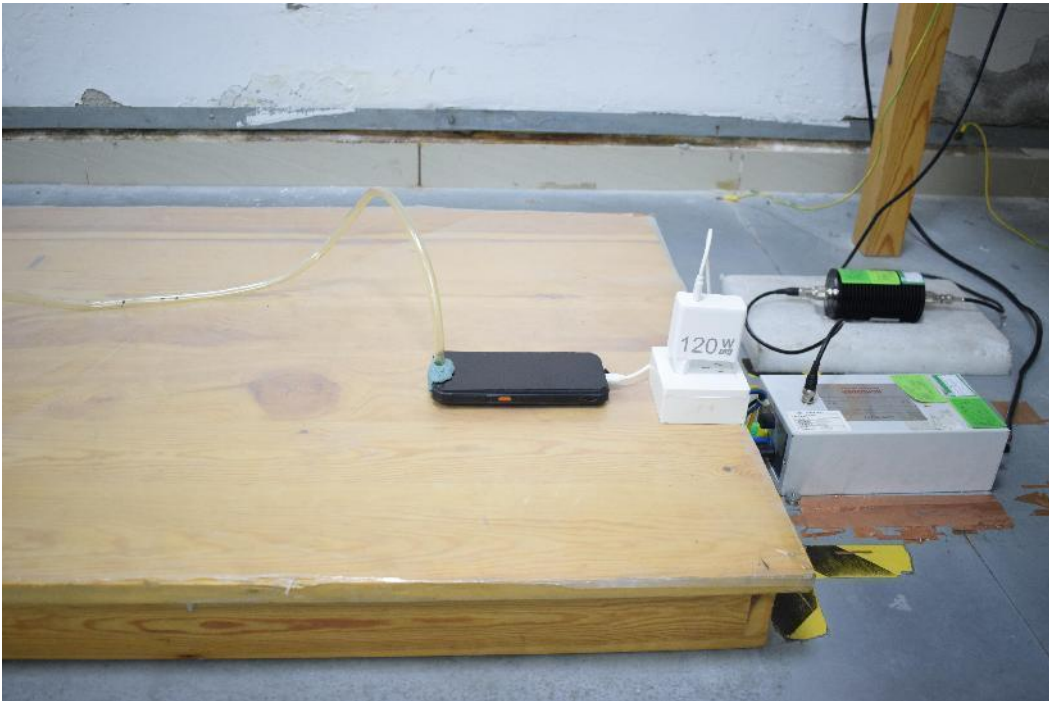
DIPS



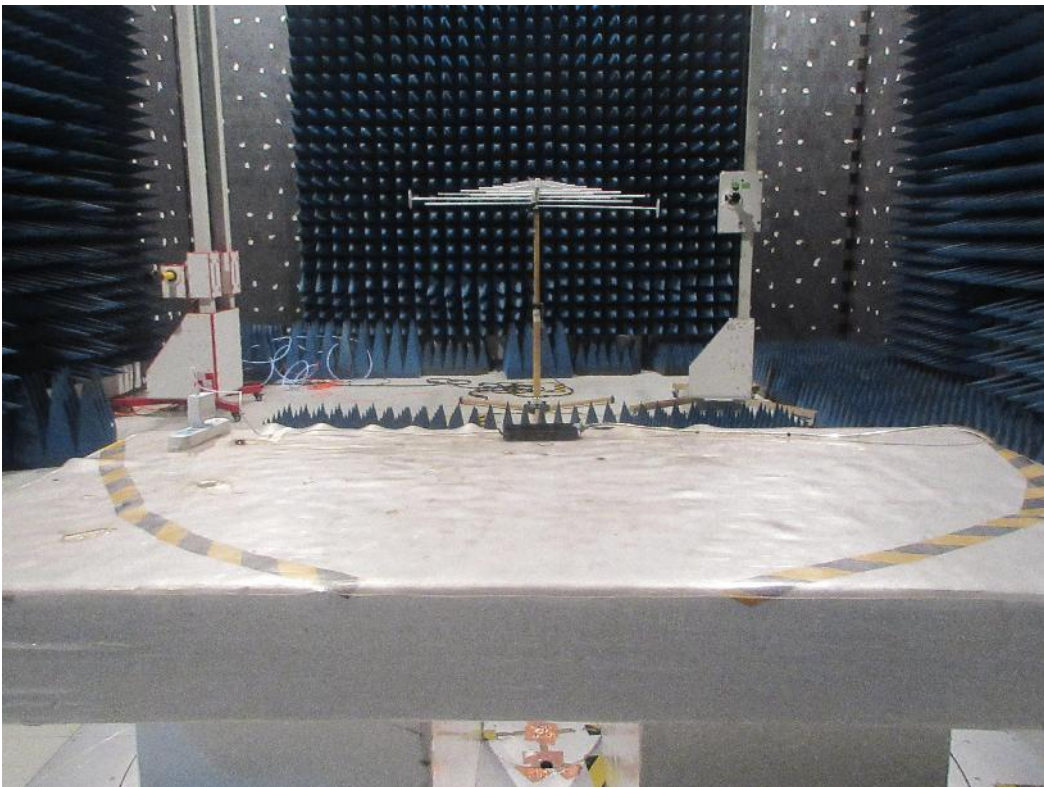
ESD



CS



RS (80 - 1000 MHz)



RS (1000 - 5000 MHz)



*****END OF THE REPORT*****